

MOSFET – Power, Single N-Channel, STD Gate, SO8FL 80 V, 1.9 mΩ, 201 A NVMFWS1D9N08X

Features

- Low QRR, Soft Recovery Body Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low QG and Capacitance to Minimize Driver Losses
- AEC Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Fre e and are RoHS Compliant

Applications

- Synchronous Rectification (SR) in DC-DC and AC-DC
- Primary Switch in Isolated DC-DC Converter
- Motor Drives
- Automotive 48 V System

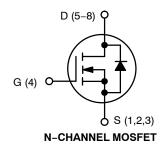
MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	80	V
Gate-to-Source Voltage		V _{GS}	±20	V
Continuous Drain Current	T _C = 25°C	I _D	201	Α
(Note 1)	T _C = 100°C		142	
Power Dissipation (Note 1)	T _C = 25°C	P_{D}	164	W
Pulsed Drain Current	T _C = 25°C,	I _{DM}	866	Α
Pulsed Source Current (Body Diode)	t _p = 100 μs	I _{SM}	866	
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55 to +175	°C
Source Current (Body Diode)		I _S	248	Α
Single Pulse Avalanche Energy	I _{PK} = 58 A (Note 3)	E _{AS}	168	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

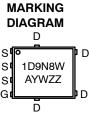
- The entire application environment impacts the thermal resistance values shown.
 They are not constants and are only valid for the particular conditions noted.
- Actual continuous current will be limited by thermal and electromechanical application board design.
- 3. EAS of 168 mJ is based on started $T_J = 25^{\circ}C$, $I_{AS} = 58$ A, $V_{DD} = 64$ V, $V_{GS} = 10$ V, 100% avalanche tested.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	1.9 mΩ @ 10 V	201 A





DFNW5 (SO-8FL) CASE 507BA



1D9N8W = Specific Device Code

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFWS1D9N08XT1G	DFNW5	1500 / Tape
	(Pb-Free)	& Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	0.91	°C/W
Thermal Resistance, Junction-to-Ambient (Notes 4, 5)	$R_{ heta JA}$	39	

^{4.} Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

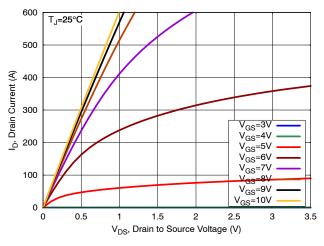
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D	= 1 mA	80			V
Drain-to-Source Breakdown Voltage (transient)	$\Delta V_{(BR)DSS}/ \Delta T_J$	I _D = 1 mA, Referer	nced to 25C		31.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	T _J = 25°C			1	μΑ
			T _J = 125°C			250	
Gate-to-Source Leakage Current	I_{GSS}	V _{GS} = 20 V, V _{DS} = 0 V				100	nA
ON CHARACTERISTICS							
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	₀ = 50 A		1.7	1.9	mΩ
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 252 μΑ	2.4		3.6	V
Negative Threshold Temperature Coefficient	$\Delta V_{GS(TH)}/ \Delta T_J$	$V_{GS} = V_{DS}, I_D =$	= 252 μA,		-7.5		mV/°C
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D}$	= 50 A		158		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				4470		
Output Capacitance	Coss	.,,			1290		_
Reverse Transfer Capacitance	C _{RSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0$) V, f = 1 MHZ		20		pF
Output Charge	Q _{OSS}				93		1
Total Gate Charge	Q _{G(TOT)}	V _{DD} = 40 V, I _D = 50	A, V _{GS} = 6 V		39		nC
		V _{DD} = 40 V, I _D = 50 A, V _{GS} = 10 V			63		
Threshold Gate Charge	Q _{G(TH)}				14		
Gate-to-Source Charge	Q _{GS}				21		nC
Gate-to-Drain Charge	Q_{GD}				10		
Gate Plateau Voltage	V_{GP}				4.7		V
Gate Resistance	R_{G}				0.8		Ω
SWITCHING CHARACTERISTICS	•			•			•
Turn-On Delay Time	t _{d(ON)}				28		
Rise Time	t _r	Resistive Load. Vo	s = 0/10 V.		12		
Turn-Off Delay Time	t _{d(OFF)}	Resistive Load, V_{GS} = 0/10 V, V_{DD} = 64 V, I_D = 50 A, R_G = 2.5 Ω			43		ns
Fall Time	t _f				7		
DRAIN-SOURCE DIODE CHARACTERISTIC	cs						
Forward Diode Voltage		I _S = 50 A.	T _J = 25°C		0.82	1.2	, , ,
		13 - 557 13	T _J = 125°C		0.66		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } I_{S} = 50 \text{ A,}$ dIS/dt = 1000 A/ μ s, $V_{DD} = 64 \text{ V}$			26		
Charge Time	ta				15		ns
Discharge Time	t _b				12		
Reverse Recovery Charge	Q _{RR}				211		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{5.} $R_{\theta JA}$ is determined by the user's board design.

TYPICAL CHARACTERISTICS

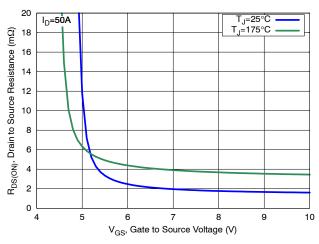


600
V_{DS}=5V
500

(£) 400
T_J=-55°C
T_J=25°C
T_J=175°C
T_J=175

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



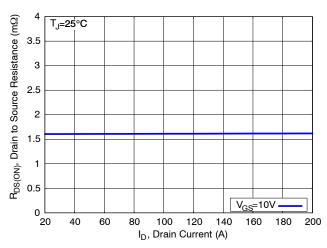
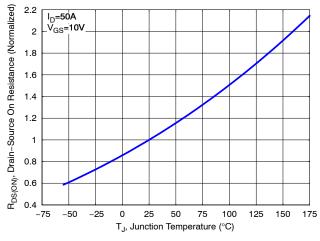


Figure 3. On-Resistance vs. Gate Voltage

Figure 4. On-Resistance vs. Drain Current



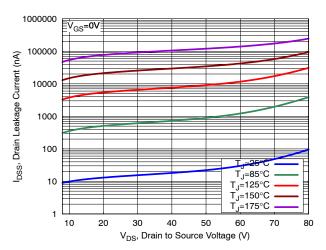


Figure 5. Normalized ON Resistance vs. Junction Temperature

Figure 6. Drain Leakage Current vs Drain Voltage

TYPICAL CHARACTERISTICS

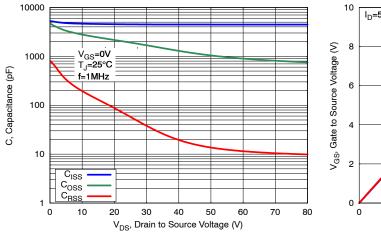
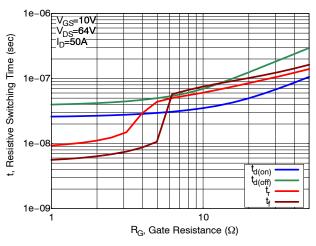


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics



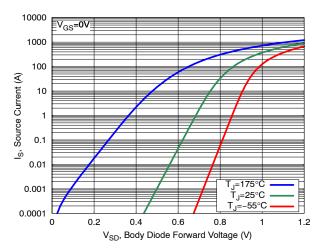
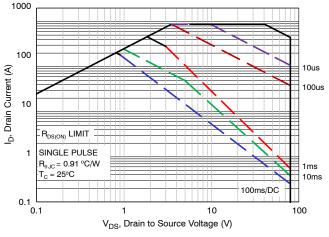


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Characteristics



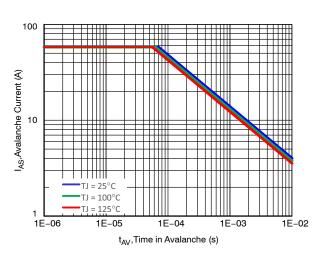
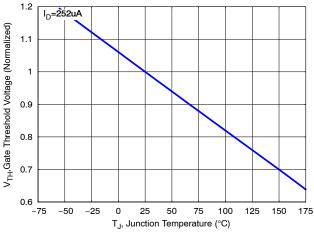


Figure 11. Safe Operating Area (SOA)

Figure 12. Avalanche Current vs Pulse Time (UIS)

TYPICAL CHARACTERISTICS



250 200 200 200 200 150 150 50 25 50 75 100 125 150 175 T_C, Case Temperature (°C)

Figure 13. Gate Threshold Voltage vs Junction Temperature

Figure 14. Maximum Current vs. Case Temperature

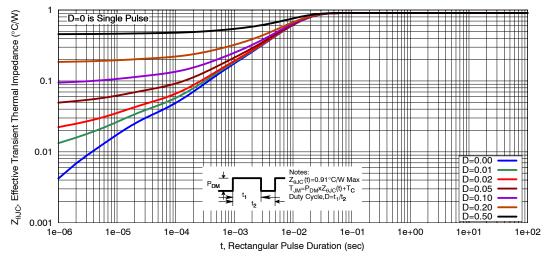


Figure 15. Transient Thermal Response

IDENTIFIER





CASE 507BA **ISSUE A**



MILLIMETERS

N□M.

0.575

0.575

0.150 REF

1.35

MAX. 1.10 0.05 0.51

0.33

5.30 5.10

4.20

6.30 6.10

3.85

0.71

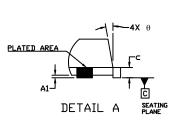
1.50

0.71



DIM

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
CONTROLLING DIMENSION: MILLIMETERS
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,
PROTRUSIONS, OR GATE BURRS.
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN
FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



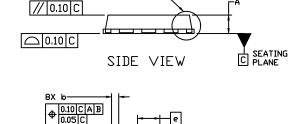
Α	0.90	1.00
A1	0.00	
b	0.33	0.41
С	0.23	0.28
D	5.00	5.15
D1	4.70	4.90
D2	3.80	4.00
Е	6.00	6.15
E1	5.70	5.90
E2	3.45	3.65
е		1.27 BSC

0.51

1.20

0.51

MIN



e/2

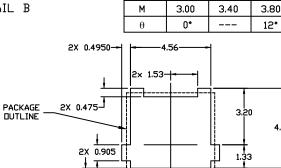
BOTTOM VIEW

-DETAIL B

DETAIL A

TOP VIEW





0.965

4X 1.00-

G

Κ

L1

GENERIC MARKING DIAGRAM*

PIN 5 (EXPOSED PAD)



= Assembly Location Α

Υ = Year W

ZZ

= Work Week = Lot Traceability

XXXXXX = Specific Device Code *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON26450H
DOGGINEITI ITOMBEITI	3070112040011

Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

4X 0.75

DESCRIPTION: DFNW5 5x6 (FULL-CUT SO8FL WF) **PAGE 1 OF 1**

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales